

Reflection From And Transmission Through Metal Layers

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Abstract: One can demonstrate that reflection from and transmission through metal layers, electro reflection and ellipsometry from metal surfaces, the surface Plasmon and Eigen modes in this layer and spheres and also the field wear the surface as encountered by the photoemission. These things cannot be under stood been qualitatively without taking plasma waves into account.

We have shown that it is not necessary to include plasma waves in the calculation of the optical response of a variety of systems containing metal surfaces and layers, but it is also possible to do so within a rather simple straight forward extension of classical Fresnel optics, then so called Hydrodynamic approximation (HD). This HD has a clear physical concept and is easy to handle mathematically. In addition to the familiar transvers electromagnetic waves, it includes longitudinal waves which are also solution of Maxwell's equation if the wave number dependence of the dielectric function i.e., spatial dispersion is taken into account in Drude-type theory. From a theoretical point of view, the HD is the simplest approximate version of "non-local optics". To discuss its relation to other phenomenological as well as the more general microscopic approaches is the second major aim of this thesis. It turns one that for many purposes the HD provides a very useful interpretation scheme. Which allows a qualitative understanding of the underlying physics with one requiring a complicated theoretical and numerical machinery.

One therefore, wants to encourage experiments to use HD for the interpretation of experiments and to start with the discussion of slight extension of standard optics. One presents the method and demonstrates its successful applications in many circumstances. This scheme of calculating the optical response of systems with conduction electrons is conceptually no more difficult than calculation of reflectivity of glass plate. One can also study the several more sophisticated treatments of the response of single metal surface to electromagnetic radiation. The relation between general forms of the response functions and additional boundary condition are discussed for the variety of phenomenological models, the HD, the specular

reflection model, the dielectric approximation the semi-classical infinite barrier model and several others. Also microscopic surface response calculations based on a quantum mechanical model containing a surface potential for the electrons are presented and their relationship to the HD and the SCIB model are illustrated. One also deals with the two surface response functions $d_{\perp}(\omega)$ and $d_{\parallel}(\omega)$ which contain the integrated effects of spatial dispersion and surface properties on measurable quantities such as reflection co-efficient or surface Plasmon dispersion. Their relation to measurements as well as to microscopic or phenomenological response calculation is discussed.

The optical surface affects occur in principle for all frequencies of the incident light and are closely related to the perturbation of the surface charges distribution. This change distribution is always induced by polarized light (i.e. light with a finite normal component of the electric field vector) at the interface between media of different bulk dielectric constants. At a metal surface, these induced screening charges are confined to a narrow but finite surface region, typically a few Angstroms thick or less in principle, a modification of the charge distribution at the surface, for instance by and atoms or an applied static electric field, affects the distribution of optically induced changes and thus the surface electromagnetic field and the response properties. The optical techniques mentioned in the beginning and so sensitive, that already minute modification of the surface constitution, for instance by means less than a monolayer of ad-atoms, can be clearly detected. In many cases, for instant of metal electrodes in electrolytic cell, these optical techniques provide the most detailed information available.

Hence one is not considering the inelastic light scatterings which occur at certain frequencies owing to transition between particular collection modes or single electron states of the metal or an adsorbate. The aim of optical instruments is to obtain information about the constitution of the surface e.g. the electronic charge distribution. Clearly, a reliable theoretical basis for the interpretation of such optical surface data is highly desirable. Unfortunately, classical Fresnel optics, which has been applied successfully to many problems of metal optics over many decades, is not sufficient for an adequate understanding of many experimental results on a variety of metal surfaces. The reason for the failure of classical optics in this context is easy to understand. The standard procedure of classical Fresnel optics¹ is based on the assumption that a boundary between media can be approximated by a plane between two homogeneous regions of different dielectric properties and that the general solution of Maxwell's equations on both sides of the interface on transverse divergence free electromagnetic waves, which are matched by the standard boundary conditions. For p-polarization, E_{\parallel} and D_{\perp} , the tangential component of the electric field and the normal component of the displacement field must be continuous. Therefore, the discontinuity of E_{\perp} and thus the induced surface charge is proportional to the discontinuity of the inverse dielectric constant $1/\epsilon(\omega)$ across the interface. In order to simulate within this approach the effect of slightly modified surfaces, for instance by adsorbed atoms or an applied electric field one has to assume a thin surface layer (thickness of the order 1 \AA) with a modified dielectric constant $\epsilon_s(\omega)$. Near the plasma frequency of this surface layer, $1/\epsilon_p(\omega)$ becomes large and the classical Fresnel theory predicts a layer induced charge and a layer optical response which has no correspondence in the experimental findings. In real systems there is no perfect screening and no singular surface charge density. The induced charges are spread over a distance of screening length, typically of the order 1 \AA in metals, and induced charges in a thin surface layer are coupled to those in the substrate. As a consequence, at the plasma frequency of the layer material no resonant plasma oscillations are found in a very thin adsorbed layer.

Since the spatial extension of optically induced charge is important for an understanding of different spectroscopy experiments near the plasma frequency, a microscopic theory of electromagnetic surface response seems a suitable basis for

the interpretation of such experiments, needless to say, that a full quantum mechanical theory, including lattice and band structure effects and treating surface and bulk response properties on equal footing, would require a tremendous numerical effort and has not been even attempted. The fine ambitious work toward this direction has been presented and reviewed by Feibelman. He considered free electron metals with a jellium model which replaces the metal by a homogeneous structure background of positive charge, thereby neglecting the lattice effects, assumed a realistic surface potential which keeps the electron inside the metal. He calculated the optical response within the random phase approximation (RPA). The results of Feibelman's microscopic theory are in remarkable good agreement with the measured photo yield spectrum of Al in a broad frequency interval including the plasma frequency. The microscopic calculation is very lengthy and depends on massive numerical work. Then complications have prohibited its ready application to a variety of optical problems even for simple metals.

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